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Substitute for form 1449A/B/PTO  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  <i>(Use as many sheets as necessary)</i>				<b>Complete If Known</b>		
				Application Number	Not Yet Assigned	
				Filing Date	10/30/2007	
				First Named Inventor	Georg Fehrenbacher	
				Art Unit	2884	
Examiner Name	Not Yet Assigned Green, Y.					
Attorney Docket Number	2693-000016/US/NP					
Sheet	1	of	1			

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/YG/	AA*	US-5,739,541	04-14-1998	Kahilainen	
/YG/	AB*	US-4,785,168-A	11-15-1988	Ruscev et al.	
/YG/	AC*	US-5,321,269-A	06-14-1994	Kitaguchi et al.	
/YG/	AD*	US-4,804,514-A	02-14-1989	Barko et al.	
/YG/	AE*	US-3,699,337-A	10-17-1972	Hoy	
/YG/	AF*	US-5,406,086-A	04-11-1995	Barthe et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
	BA	DE-26 29 960-C2	01-18-1979			
/YG/	BB	DE-694 17 770-T2	12-02-1999			✓
/YG/	BC	DE-100 42 076-A1	05-10-2001			✓
	BD	DE-266 702-A7	04-11-1994			
/YG/	BE	DE-101 32 550-A1	01-30-2003			✓
	BF	DE-100 07 043-A1	09-31-2000			
/YG/	BG	CH-508 887-A	06-15-1971			
/YG/	BH	DD-134 392-A	02-21-1979			
/YG/	BI	JP-63 154984-A	06-28-1988			
/YG/	BJ	JP-2000 206261-A	07-28-2000			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. \* CITE NO.: Those application(s) which are marked with an single asterisk (\*) next to the Cite No. are not supplied (under 37 CFR 1.98(a)(2)(iii)) because that application was filed after June 30, 2003 or is available in the IFW. <sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> See Kinds Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
/YG/		Luszk-Bhadra M., et al: "Development of personal neutron dosimeters at the PTB and first measurements in the space station MIR", Radiation Measurements, Elsevier Sciences Publishers, Barking, GB, Bd. 33, Nr. 3, June 2001 (2001-06), Pages 305-312, XP004249148; ISSN: 1350-4487	

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature	/Yara Green/	Date Considered	09/20/2007
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STO/smc



FORM HDP-1449 (Based on Form PTO-1449)

**PATENT AND TRADEMARK OFFICE  
INFORMATION DISCLOSURE CITATION**  
(Use several sheets if necessary)

Sheet 1 of 1

ATTORNEY DOCKET NO.	SERIAL NO.
2693-000016/US/NP	10/561,287
APPLICANT	
Georg FEHRENBACHER	
FILING DATE	GROUP
20 December 2005	To be assigned

**U.S. PATENT DOCUMENTS**

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
YG/1.		5,081,362	01/14/1992	Vargo		

**FOREIGN PATENT DOCUMENTS**

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	No
YG/1.		DE 32 01 243 A1	01/09/1983	Germany		Abstract	
YG/ 2.		DD 134 392 A	02/21/1979	Germany			X
YG/ 3.		CH 508 887 A	07/30/1971	Switzerland			X

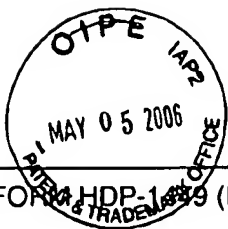
**OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)**

Ref. Desig.	Examiner's Initials	
YG/1.		Delaney et al., "Radiation Detectors - Physical Principles and Applications," Clarendon Press, Oxford, 1992, pages 62-65
YG/2.		Jain et al., "Measurement of high energy neutrons by fission reactions," Radiation Measurements 34, 2001, pages 129-132
YG/3.		Olsher et al., "WENDI, An Improved Neutron Rem Meter," Health Physics, Vol. 79, No. 2, August 2000, pages 170-181

Examiner: /Yara Green/

Date Considered: 09/20/2007

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FORM HDP-1 (Based on Form PTO-1449)

**PATENT AND TRADEMARK OFFICE  
INFORMATION DISCLOSURE CITATION**  
(Use several sheets if necessary)

Sheet 1 of 1

ATTORNEY DOCKET NO.	SERIAL NO.
2693-000016/US/NP	10/561,287
APPLICANT	
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YG/1.		5,406,086	04/1995	Barthe et al.		
YG/2.		5,312,269	06/1994	Kitaguchi et al.		
YG/3.		4,804,514	02/1989	Bartko et al.		
YG/4.		4,785,168	06/1988	Awakowicz et al.		
YG/5.		3,699,337	10/1972	Hoy		

**FOREIGN PATENT DOCUMENTS**

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	No
YG/1.		508887	06/15/1971	CH		Abstract	
YG/2.		134392	02/21/1979	DD		Abstract	
YG/3.		63154984	06/14/1994	JP		Abstract	
YG/4.		09021881	01/21/1994	JP		Abstract	
YG/5.		2000206261	07/28/2000	JP		Abstract	
YG/6.		3201243	09/01/1983	DE		Abstract	

**OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)**

Ref. Desig.	Examiner's Initials	
YG/1.		European Search Report dated 30 March 2006; International Search Report dated 22 June 2003

Examiner: /Yara Green/

Date Considered: 09/20/2007

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